











### SN54HC32, SN74HC32

SCLS200E - DECEMBER 1982-REVISED JULY 2016

# SNx4HC32 Quadruple 2-Input Positive-OR Gates

## **Features**

Wide Operating Voltage Range: 2 V to 6 V

Outputs Can Drive Up to 10 LSTTL Loads

Low Power Consumption I<sub>CC</sub>: 20 µA (Maximum)

Typical t<sub>pd</sub>: 8 ns

±4-mA Output Drive at 5 V

Low Input Current: 1 µA (Maximum)

## **Applications**

- Education
- Toys
- Musical Instruments
- Medical Healthcare and Fitness
- Grid Infrastructure
- Electronic Point of Sale
- Test and Measurement
- Factory Automation and Control
- **Building Automation**

## 3 Description

The SNx4HC32 devices contain four independent 2-input OR gates. They perform the boolean function  $Y = \overline{A \cdot B}$  or Y = A + B in positive logic.

### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
SN54HC32J	CDIP (14)	19.94 mm × 7.62 mm
SN54HC32W	CFP (14)	9.21 mm × 7.11 mm
SN54HC32FK	LCCC (20)	8.89 mm × 8.89 mm
SN74HC32D	SOIC (14)	4.90 mm × 3.91 mm
SN74HC32DB	SSOP (14)	6.20 mm × 5.30 mm
SN74HC32N	PDIP (14)	19.30 mm × 6.35 mm
SN74HC32NS	SO (14)	10.30 mm × 5.30 mm
SN74HC32PW	TSSOP (14)	5.00 mm × 4.40 mm

<sup>(1)</sup> For all available packages, see the orderable addendum at the end of the data sheet.

## **Logic Diagram (Positive Logic)**





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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

### Changes from Revision D (August 2003) to Revision E

Page

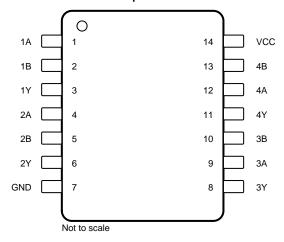
Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section
 Removed Ordering Information table
 Updated values in the Thermal Information tables to align with JEDEC standards

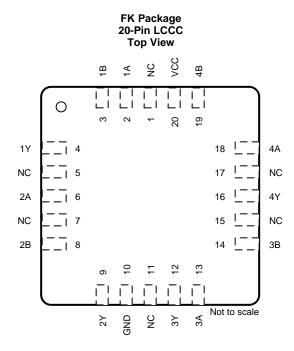
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# 5 Pin Configuration and Functions

D, DB, J, N, NS, PW, W Package 14-Pin SOIC, SSOP, CDIP, PDIP, SOP, TSSOP, CFP Top View





#### **Pin Functions**

	PIN		PIN			
NAME	D, DB, J, N, NS, PW, W	FK	I/O	DESCRIPTION		
1A	1	2	I	Gate 1 input A		
1B	2	3	- 1	Gate 1 input B		
1Y	3	4	0	Gate 1 output		
2A	4	6	1	Gate 2 input A		
2B	5	8	I	Gate 2 input B		
2Y	6	9	0	Gate 2 output		
3A	9	13	I	Gate 3 input A		
3B	10	14	1	Gate 3 input B		
3Y	8	12	0	Gate 3 output		
4A	12	18	I	Gate 4 input A		
4B	13	19	I	Gate 4 input B		
4Y	11	16	0	Gate 4 output		
GND	7	10	_	Ground		
NC	_	1, 5, 7, 11, 15, 17	_	No internal connection		
V <sub>CC</sub>	14	20	_	Power supply		

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## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	7	V
I <sub>IK</sub>	Input clamp current <sup>(2)</sup>	$V_I < 0$ or $V_I > V_{CC}$		±20	mA
I <sub>OK</sub>	Output clamp current <sup>(2)</sup>	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±25	mA
	Continuous current through V <sub>CC</sub> or GND			±50	mA
TJ	T <sub>J</sub> Operating virtual junction temperature			150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings: SN74HC32

			VALUE	UNIT
V	Floatroatatia diacharga	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	\/
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±750	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted) (1)

			MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2	5	6	V
		V <sub>CC</sub> = 2 V	1.5			
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 4.5 V	3.15			V
		$V_{CC} = 6 V$	4.2			
		V <sub>CC</sub> = 2 V			0.5	
V <sub>IL</sub> Low-level input voltage	V <sub>CC</sub> = 4.5 V			1.35	V	
	V	V <sub>CC</sub> = 6 V			1.8	
VI	Input voltage		0		V <sub>CC</sub>	V
Vo	Output voltage		0		$V_{CC}$	V
		V <sub>CC</sub> = 2 V			1000	
Δt/Δν	Input transition rise or fall time	V <sub>CC</sub> = 4.5 V			500	ns
		V <sub>CC</sub> = 6 V			400	
_	Operating free air temperature	SN54HC32	-55		125	۰.
T <sub>A</sub>	Operating free-air temperature	SN74HC32	-40		85	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to *Implications of Slow or Floating CMOS Inputs* application report.

Product Folder Links: SN54HC32 SN74HC32

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<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 6.4 Thermal Information: SN54HC32

		SN54HC32				
THERMAL METRIC <sup>(1)</sup>		CDIP (J)	CFP (W)	LCCC (FK)	UNIT	
		14 PINS	14 PINS	20 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	_	_	_	°C/W	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	54.9	88.3	61	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	80.1	156	59.6	°C/W	
ΨЈТ	Junction-to-top characterization parameter	_	_	_	°C/W	
ΨЈВ	Junction-to-board characterization parameter	_	_	_	°C/W	
R <sub>0</sub> JC(bot)	Junction-to-case (bottom) thermal resistance	25.1	15.2	11.7	°C/W	

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

## 6.5 Thermal Information: SN74HC32

			SN74HC32					
	THERMAL METRIC <sup>(1)</sup>	SOIC (D)	SSOP (DB)	PDIP (N)	SOP (NS)	TSSOP (PW)	UNIT	
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	90.1	105.4	54.9	88.8	119.6	°C/W	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	50.3	57.3	42.5	46.5	48.4	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	44.4	52.7	34.7	47.6	61.3	°C/W	
ΨЈТ	Junction-to-top characterization parameter	17.9	22.6	27.9	16.8	5.6	°C/W	
ΨЈВ	Junction-to-board characterization parameter	44.1	52.2	34.6	47.2	60.7	°C/W	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	_	_	_	_	_	°C/W	

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 6.6 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			TYP	MAX	UNIT
			V <sub>CC</sub> = 2 V	1.9	1.998		
		$I_{OH} = -20 \mu A$	V <sub>CC</sub> = 4.5 V	4.4	4.499		
			V <sub>CC</sub> = 6 V	5.9	5.999		
		$I_{OH} = -4 \text{ mA}, V_{CC} = 4.5 \text{ V}$	T <sub>A</sub> = 25°C	3.98	4.3		
$V_{OH}$	$V_I = V_{IH}$ or $V_{IL}$		SN54HC32	3.7			V
			SN74HC32	3.84			
			T <sub>A</sub> = 25°C	5.48	5.8		
		$I_{OH} = -5.2 \text{ mA}, V_{CC} = 6 \text{ V}$	SN54HC32	5.2			
			SN74HC32	5.34			

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Product Folder Links: SN54HC32 SN74HC32



## **Electrical Characteristics (continued)**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
				V <sub>CC</sub> = 2 V		0.002	0.1	
			$I_{OL} = 20 \mu A$	$V_{CC} = 4.5 \text{ V}$		0.001	0.1	
				$V_{CC} = 6 V$		0.001	0.1	
				$T_A = 25^{\circ}C$		0.17	0.26	
$V_{OL}$		$V_I = V_{IH}$ or $V_{IL}$	$I_{OL} = 4 \text{ mA}, V_{CC} = 4.5 \text{ V}$	SN54HC32			0.4	V
				SN74HC32			0.33	
		Io	I <sub>OL</sub> = 5.2 mA, V <sub>CC</sub> = 6 V	$T_A = 25^{\circ}C$		0.15	0.26	
				SN54HC32			0.4	
				SN74HC32			0.33	
		V V 070 V	CV	$T_A = 25^{\circ}C$		±0.1	±100	nA
I <sub>I</sub>		$V_I = V_{CC}$ or 0, $V_C$	CC = 0 A	SNx4HC32			±1000	ΠA
				$T_A = 25^{\circ}C$			2	
I <sub>CC</sub>		$V_I = V_{CC}$ or 0, $I_O$	$= 0, V_{CC} = 6 V$	SN54HC32			40	μΑ
				SN74HC32			20	
Ci		V <sub>CC</sub> = 2 V to 6 V	,	·		3	10	pF
C <sub>pd</sub>	Power dissipation capacitance per gate	$T_A = 25^{\circ}C$ , no lo	ad			20		pF

# 6.7 Switching Characteristics

over operating free-air temperature range (unless otherwise noted; see Figure 4)

PARAMETER	TEST	CONDITIONS		MIN	TYP	MAX	UNIT
			T <sub>A</sub> = 25°C		50	100	
		$V_{CC} = 2 V$	SN54HC32			150	
			SN74HC32			125	
			T <sub>A</sub> = 25°C		10	20	
t <sub>pd</sub>	$C_L = 50 \text{ pF}, \text{ from A or B (input)}$ to Y (output)	$V_{CC} = 4.5 \text{ V}$	SN54HC32			30	ns
	to i (output)		SN74HC32			25	
			T <sub>A</sub> = 25°C		8	17	+
		$V_{CC} = 6 V$	SN54HC32			25	
			SN74HC32			21	
			T <sub>A</sub> = 25°C		38	75	
		$V_{CC} = 2 V$	SN54HC32			110	
			SN74HC32			95	
			T <sub>A</sub> = 25°C		8	15	
t <sub>t</sub>	$C_L = 50 \text{ pF}, \text{ to Y (output)}$	$V_{CC} = 4.5 \text{ V}$	SN54HC32			22	ns
			SN74HC32			19	
			T <sub>A</sub> = 25°C		6	13	
		V <sub>CC</sub> = 6 V	SN54HC32			19	
			SN74HC32			16	

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# 6.8 Typical Characteristics

 $T_A = 25^{\circ}C$  and  $C_L = 50$  pF

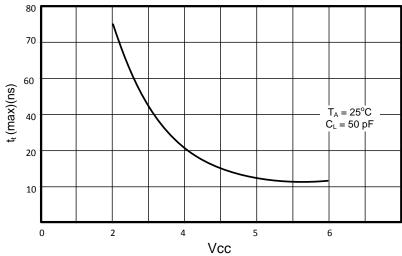


Figure 1. t<sub>t</sub> vs V<sub>CC</sub>



### 7 Parameter Measurement Information

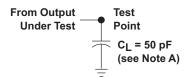
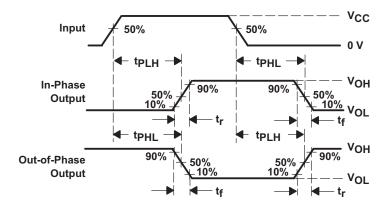


Figure 2. Load Current



Figure 3. Input Rise and Fall Times



NOTES: A. C<sub>1</sub> includes probe and test-fixture capacitance.

- B. Phase relationship between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, ZO = 50  $\Omega$ ,  $t_r$  = 6 ns,  $t_f$  = 6 ns.
- C. The outputs are measured one at a time with one input transition per measurements.
- D.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Figure 4. Propagation Delay and Output Transition Times

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## 8 Detailed Description

#### 8.1 Overview

The SNx4HC32 devices are quad 2-input OR gates. These devices are members of the High-Speed CMOS (HC) logic family. The HC family of logic is optimized to operate with a 5-V supply, is low noise without characteristic overshoot and undershoot, has low power consumption, small propagation delay, balanced propagation delay and transition times, and operates over a wide temperature range.

### 8.2 Functional Block Diagram



Figure 5. Logic Diagram (Positive Logic)

## 8.3 Feature Description

### 8.3.1 Operating Voltage Range

The SNx4HC series of devices offer a wide operating voltage range from 2 V to 6 V.

#### 8.3.2 LSTTL Loads

The outputs of the SNx4HC series can drive up to 10 LSTTL loads.

#### 8.3.3 Low Power Consumption

The SNx4HC32 offers low power consumption of 20  $\mu$ A (maximum).

#### 8.3.4 Output Drive Capability

At 5 V, the outputs have ±4 mA of output drive capability.

## 8.3.5 Low Input Current Leakage

Inputs have low input current leakage of 1 µA (maximum).

#### 8.4 Device Functional Modes

Table 1 lists the functional modes of SNx4HC32.

Table 1. Function Table (Each Gate)

INP	OUTPUT	
Α	В	Υ
Н	X	Н
X	Н	Н
L	L	L

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## 9 Application and Implementation

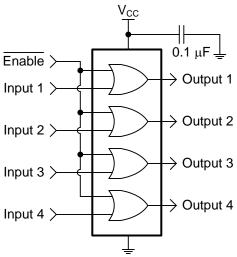
#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 9.1 Application Information

The SNx4HC32 is an extremely versatile device with far more available applications than could be listed here. The application chosen as an example is using all four <u>OR</u> gates in a single package to provide a four channel output enable from a single active low enable signal (Enable). This circuit outputs a logic HIGH on all channels when disabled (Enable is HIGH), and passes the input signals when enabled (Enable is LOW).

## 9.2 Typical Application



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Using a quad OR gate as a 4-channel active low enable with high output off state.

Figure 6. Typical Application Schematic

#### 9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive also creates fast edges into light loads, so routing and load conditions must be considered to prevent ringing.

The minimum output pulse time is approximately three times  $t_{pd}$  from *Switching Characteristics* for the selected  $V_{CC}$ , device, and temperature range.

## 9.2.2 Detailed Design Procedure

#### Logic

- · All four input channels are to be enabled or disabled simultaneously
- The enable signal is active low (LOW = enabled, HIGH = disabled)
- All four outputs are to output logic HIGH while disabled

#### Inputs

- Each input must follow requirements specified in Absolute Maximum Ratings:
  - Avoid exceeding input voltages

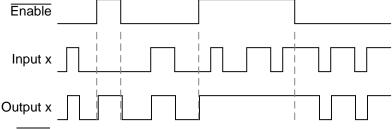
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## **Typical Application (continued)**

- If input voltages ratings must be exceeded, ensure that the maximum input current ratings are not exceeded.
- Ensure that the input signals have edge rates that are equal to or faster than that listed in *Recommended Operating Conditions*. Slower signals can cause incorrect behavior and possibly damage to the part.
- Each output must also follow requirements in Absolute Maximum Ratings:
  - Avoid bus contention by only connecting outputs together when inputs are tied together directly.
  - Avoid forcing output voltages outside those specified in Absolute Maximum Ratings.
  - If output voltage ratings must be exceeded, ensure that the maximum output current ratings are not exceeded.
  - Ensure that the total current output does not exceed the continuous current through V<sub>CC</sub> or GND listed in Absolute Maximum Ratings.

### 9.2.3 Application Curves



Dotted lines indicate Enable signal changes

Figure 7. Application Timing Diagram



## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in *Recommended Operating Conditions*. Each  $V_{CC}$  pin must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends a 0.1- $\mu$ F bypass capacitor. If there are multiple  $V_{CC}$  pins, TI recommends a 0.01- $\mu$ F or 0.022- $\mu$ F bypass capacitors for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. Two bypass capacitors of value 0.1- $\mu$ F and 1- $\mu$ F are commonly used in parallel. For best results, install the bypass capacitor(s) as close to the power pin as possible.

## 11 Layout

## 11.1 Layout Guidelines

When using multiple bit logic devices, inputs must not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified in *Absolute Maximum Ratings* are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally they are tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient. It is acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it disables the outputs section of the part when asserted. This does not disable the input section of the I/Os so they also cannot float when disabled.

#### 11.2 Layout Example

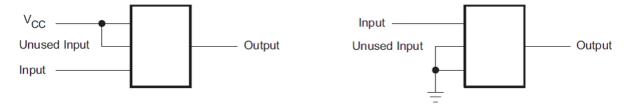


Figure 8. Layout Recommendation

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## 12 Device and Documentation Support

## 12.1 Documentation Support

#### 12.1.1 Related Documentation

For related documentation see the following:

Implications of Slow or Floating CMOS Inputs (SCBA004)

#### 12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 2. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN54HC32	Click here	Click here	Click here	Click here	Click here	
SN74HC32	SN74HC32 Click here		Click here	Click here	Click here	

## 12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

## 12.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community T's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.5 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

## 12.6 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 12.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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## **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)	0010				(2)	(6)	(3)		(4/5)	
5962-8404501VCA	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-8404501VC A SNV54HC32J	Sample
5962-8404501VDA	ACTIVE	CFP	W	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-8404501VD	
3302-0404301VDA	ACTIVE	CIT	VV	14	'	100	Call II	N/Alorr kg Type	-55 to 125	A SNV54HC32W	Sample
84045012A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	84045012A	
04043012A	ACTIVE	Loco	FK	20	'	100	FOST-FLATE	N/Alorry Type	-55 to 125	SNJ54HC 32FK	Sample
8404501CA	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	8404501CA SNJ54HC32J	Sample
8404501DA	ACTIVE	CFP	W	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	8404501DA SNJ54HC32W	Samples
JM38510/65201B2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	JM38510/ 65201B2A	Samples
JM38510/65201BCA	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	JM38510/ 65201BCA	Samples
JM38510/65201BDA	ACTIVE	CFP	W	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	JM38510/ 65201BDA	Samples
M38510/65201B2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	JM38510/ 65201B2A	Samples
M38510/65201BCA	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	JM38510/ 65201BCA	Samples
M38510/65201BDA	ACTIVE	CFP	W	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	JM38510/ 65201BDA	Samples
SN54HC32J	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	SN54HC32J	Samples
SN74HC32D	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Samples
SN74HC32DBR	ACTIVE	SSOP	DB	14	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Samples
SN74HC32DE4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Samples
SN74HC32DR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	HC32	Samples





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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74HC32DRE4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Samples
SN74HC32DRG4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Samples
SN74HC32DT	ACTIVE	SOIC	D	14	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SN74HC32N	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC32N	Sample
SN74HC32NE4	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC32N	Sample
SN74HC32NSR	ACTIVE	so	NS	14	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SN74HC32PW	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SN74HC32PWG4	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SN74HC32PWR	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SN74HC32PWRG4	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SN74HC32PWT	ACTIVE	TSSOP	PW	14	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SN74HC32PWTG4	ACTIVE	TSSOP	PW	14	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC32	Sample
SNJ54HC32FK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	84045012A SNJ54HC 32FK	Sample
SNJ54HC32J	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	8404501CA SNJ54HC32J	Sampl
SNJ54HC32W	ACTIVE	CFP	W	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	8404501DA SNJ54HC32W	Sampl

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE**: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

## PACKAGE OPTION ADDENDUM



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**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54HC32. SN54HC32-SP. SN74HC32:

Catalog: SN74HC32, SN54HC32

Military: SN54HC32

Space: SN54HC32-SP

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

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## **PACKAGE OPTION ADDENDUM**

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- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC32DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HC32DR	SOIC	D	14	2500	330.0	16.8	6.5	9.5	2.1	8.0	16.0	Q1
SN74HC32DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HC32DRG4	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HC32DRG4	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HC32DT	SOIC	D	14	250	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HC32PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HC32PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HC32PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HC32PWT	TSSOP	PW	14	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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\*All dimensions are nominal

All difficultions are nominal						1	
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC32DR	SOIC	D	14	2500	333.2	345.9	28.6
SN74HC32DR	SOIC	D	14	2500	364.0	364.0	27.0
SN74HC32DR	SOIC	D	14	2500	367.0	367.0	38.0
SN74HC32DRG4	SOIC	D	14	2500	367.0	367.0	38.0
SN74HC32DRG4	SOIC	D	14	2500	333.2	345.9	28.6
SN74HC32DT	SOIC	D	14	250	210.0	185.0	35.0
SN74HC32PWR	TSSOP	PW	14	2000	367.0	367.0	35.0
SN74HC32PWR	TSSOP	PW	14	2000	364.0	364.0	27.0
SN74HC32PWRG4	TSSOP	PW	14	2000	367.0	367.0	35.0
SN74HC32PWT	TSSOP	PW	14	250	367.0	367.0	35.0

# W (R-GDFP-F14)

# CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14



CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
   Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
   Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



# D (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



## DB (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

# FK (S-CQCC-N\*\*)

# LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. Falls within JEDEC MS-004



## **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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